

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10521620	HEUER ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Lewis, Cheryl	2167

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	100, 101, and 200	1/2/2009	CL

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
searched WEST US Patents, Pre-Grant Publications database, JPO Abstracts, and EPO Abstracts	1/2/2009	CL
searched Derwent Patents and IBM Disclosure	1/2/2009	CL
searched ACM Library and Google Scholar	1/2/2009	CL
text searched class: 707 and subclasses: 100, 101, and 200	1/2/2009	CL
Inventor Name Search	1/2/2009	CL

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
same as	above	1/2/2009	CL

	/C. L./ Primary Examiner.Art Unit 2167
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